

<b>Notice of References Cited</b>	Application/Control No. 09/986,359	Applicant(s)/Patent Under Reexamination CLARK, BRIAN HALL	
	Examiner Donald Loney	Art Unit 1772	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,622,430	11-1971	Jurisich, Peter L.	428/118
	B	US-4,411,121	10-1983	Blacklin et al.	52/789.1
	C	US-4,996,950	03-1991	Le Mer, Joseph	122/260
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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	M	US-			

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